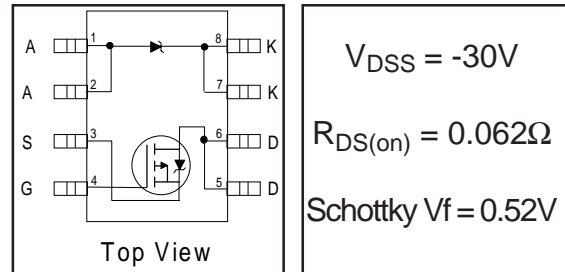


# IRF7321D2

FETKY™ MOSFET & Schottky Diode

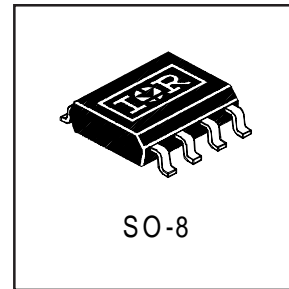
- Co-packaged HEXFET® Power MOSFET and Schottky Diode
- Ideal For Buck Regulator Applications
- P-Channel HEXFET®
- Low  $V_F$  Schottky Rectifier
- Generation 5 Technology
- SO-8 Footprint



## Description

The FETKY™ family of Co-packaged HEXFETs and Schottky diodes offer the designer an innovative board space saving solution for switching regulator and power management applications. Generation 5 HEXFETs utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. Combining this technology with International Rectifier's low forward drop Schottky rectifiers results in an extremely efficient device suitable for use in a wide variety of portable electronics applications.

The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics. The SO-8 package is designed for vapor phase, infrared or wave soldering techniques.



SO-8

## Absolute Maximum Ratings ( $T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

	Parameter	Maximum	Units
$I_D @ T_A = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ -10\text{V}$	-4.7	A
$I_D @ T_A = 70^\circ\text{C}$		-3.8	
$I_{DM}$		Pulsed Drain Current ①	
$P_D @ T_A = 25^\circ\text{C}$	Power Dissipation	2.0	W
$P_D @ T_A = 70^\circ\text{C}$		1.3	
	Linear Derating Factor	16	mW/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$dv/dt$	Peak Diode Recovery $dv/dt$ ②	-5.0	V/ns
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to +150	°C

## Thermal Resistance Ratings

	Parameter	Maximum	Units
$R_{\theta JA}$	Junction-to-Ambient ④	62.5	°C/W

### Notes:

- ① Repetitive rating – pulse width limited by max. junction temperature (see fig. 11)
- ②  $I_{SD} \leq -2.9\text{A}$ ,  $di/dt \leq -77\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$
- ③ Pulse width  $\leq 300\mu\text{s}$  – duty cycle  $\leq 2\%$
- ④ Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .

# IRF7321D2

International  
Rectifier

## MOSFET Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-30	—	—	V	$V_{GS} = 0V, I_D = -250\mu A$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	0.042	0.062	$\Omega$	$V_{GS} = -10V, I_D = -4.9A$ ③
		—	0.076	0.098		$V_{GS} = -4.5V, I_D = -3.6A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	-1.0	—	—	V	$V_{DS} = V_{GS}, I_D = -250\mu A$
$g_{fs}$	Forward Transconductance	—	7.7	—	S	$V_{DS} = -15V, I_D = -4.9A$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	-1.0	$\mu A$	$V_{DS} = -24V, V_{GS} = 0V$
		—	—	-25		$V_{DS} = -24V, V_{GS} = 0V, T_J = 55^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = -20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = 20V$
$Q_g$	Total Gate Charge	—	23	34	nC	$I_D = -4.9A$
$Q_{gs}$	Gate-to-Source Charge	—	3.8	5.7		$V_{DS} = -15V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	5.9	8.9		$V_{GS} = -10V$ , See Fig. 6 ③
$t_{d(on)}$	Turn-On Delay Time	—	13	19		$V_{DD} = -15V$
$t_r$	Rise Time	—	13	20	ns	$I_D = -1.0A$
$t_{d(off)}$	Turn-Off Delay Time	—	34	51		$R_G = 6.0\Omega$
$t_f$	Fall Time	—	32	48		$R_D = 15\Omega$ , ③
$C_{iss}$	Input Capacitance	—	710	—		$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	380	—	pF	$V_{DS} = -25V$
$C_{rss}$	Reverse Transfer Capacitance	—	180	—		$f = 1.0\text{MHz}$ , See Fig. 5

## MOSFET Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	-2.5	A	
$I_{SM}$	Pulsed Source Current (Body Diode)	—	—	-30		
$V_{SD}$	Body Diode Forward Voltage	—	-0.78	-1.0	V	$T_J = 25^\circ\text{C}, I_S = -1.7A, V_{GS} = 0V$
$t_{rr}$	Reverse Recovery Time (Body Diode)	—	44	66	ns	$T_J = 25^\circ\text{C}, I_F = -1.7A$
$Q_{rr}$	Reverse Recovery Charge	—	42	63	nC	$di/dt = 100A/\mu s$ ③

## Schottky Diode Maximum Ratings

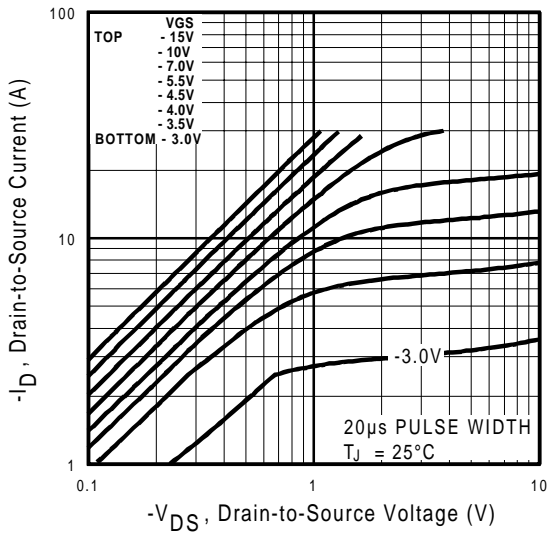
	Parameter	Max.	Units	Conditions
$I_f$ (av)	Max. Average Forward Current	3.2	A	50% Duty Cycle. Rectangular Wave, $T_c = 25^\circ\text{C}$ See Fig.14
		2.0		
$I_{SM}$	Max. peak one cycle Non-repetitive Surge current	200	A	Following any rated load condition & with $V_{rrm}$ applied
		20		

## Schottky Diode Electrical Specifications

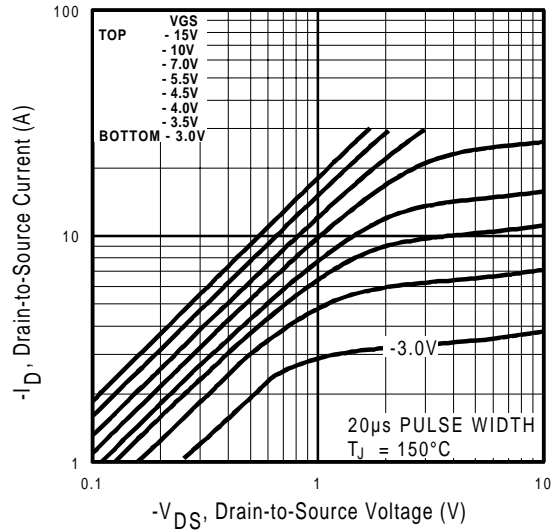
	Parameter	Max.	Units	Conditions
$V_{fm}$	Max. Forward voltage drop	0.57	V	$I_f = 3.0, T_J = 25^\circ\text{C}$
		0.77		$I_f = 6.0, T_J = 25^\circ\text{C}$
		0.52		$I_f = 3.0, T_J = 125^\circ\text{C}$
		0.79		$I_f = 6.0, T_J = 125^\circ\text{C}$
$I_{rm}$	Max. Reverse Leakage current	0.30	mA	$V_r = 30V, T_J = 25^\circ\text{C}$
		37		$T_J = 125^\circ\text{C}$
$C_t$	Max. Junction Capacitance	310	pF	$V_r = 5V_{dc}$ ( 100kHz to 1 MHz) $25^\circ\text{C}$
$dv/dt$	Max. Voltage Rate of Charge	4900	V/ $\mu s$	Rated $V_r$

(HEXFET is the reg. TM for International Rectifier Power MOSFET's)

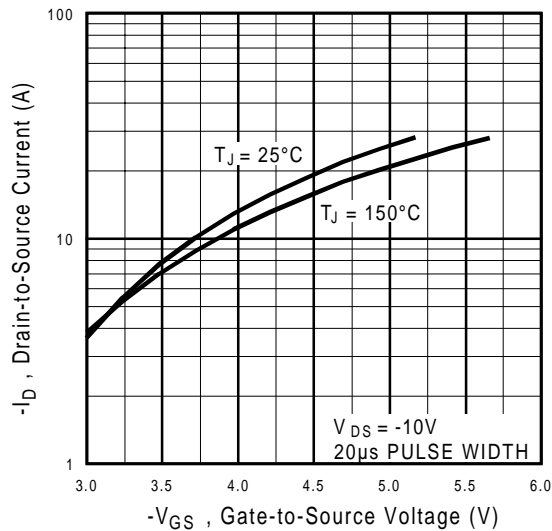
## Power Mosfet Characteristics



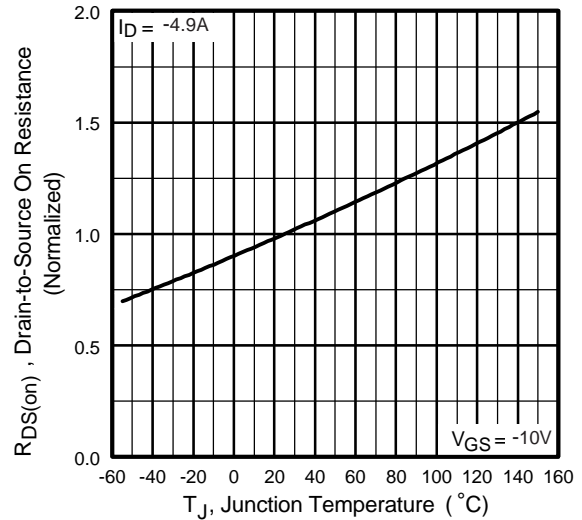
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics

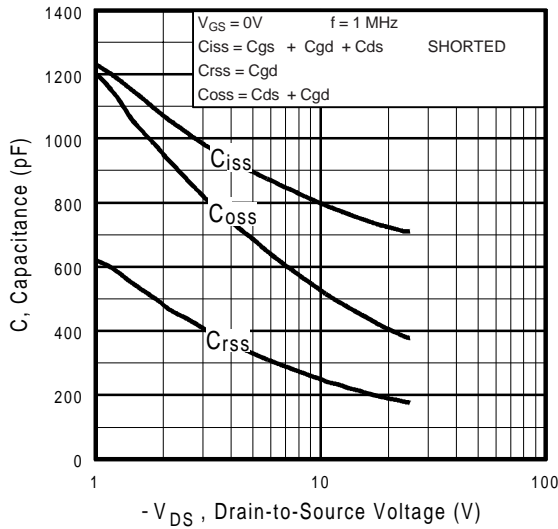


**Fig 3.** Typical Transfer Characteristics

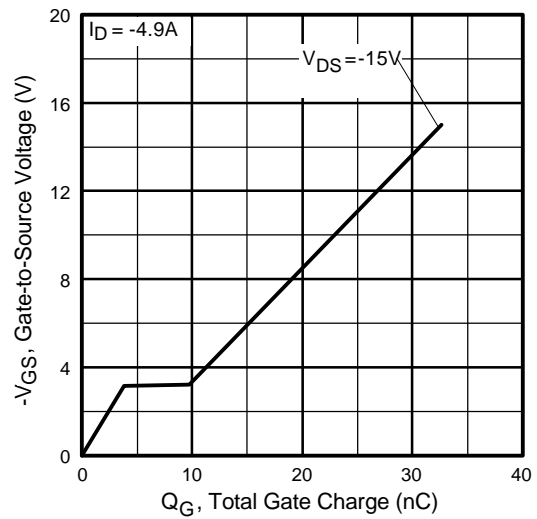


**Fig 4.** Normalized On-Resistance Vs. Temperature

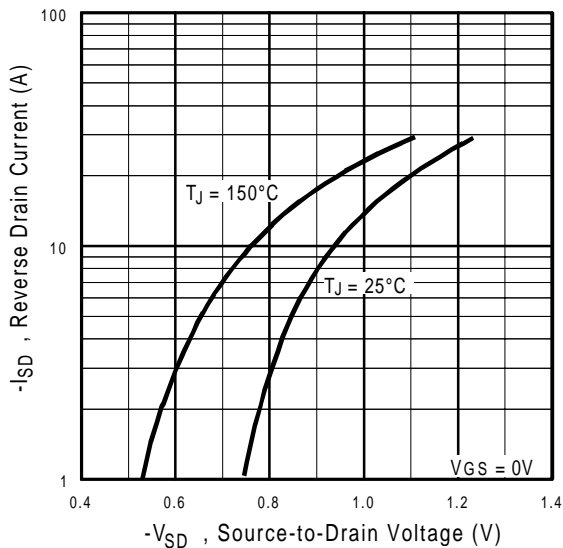
## Power Mosfet Characteristics



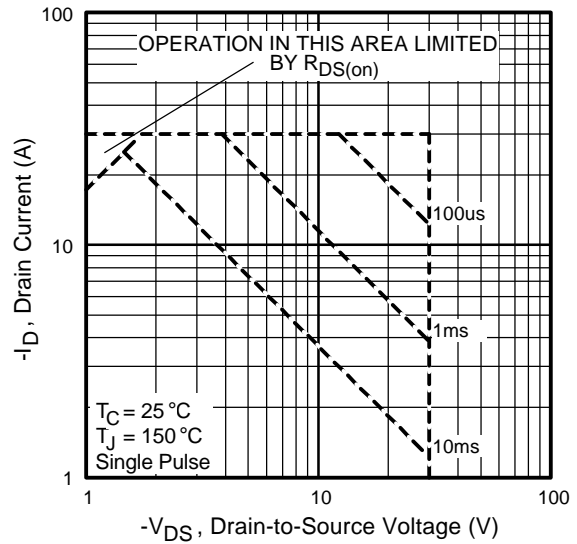
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



**Fig 7.** Typical Source-Drain Diode Forward Voltage



**Fig 8.** Maximum Safe Operating Area

Power Mosfet Characteristics

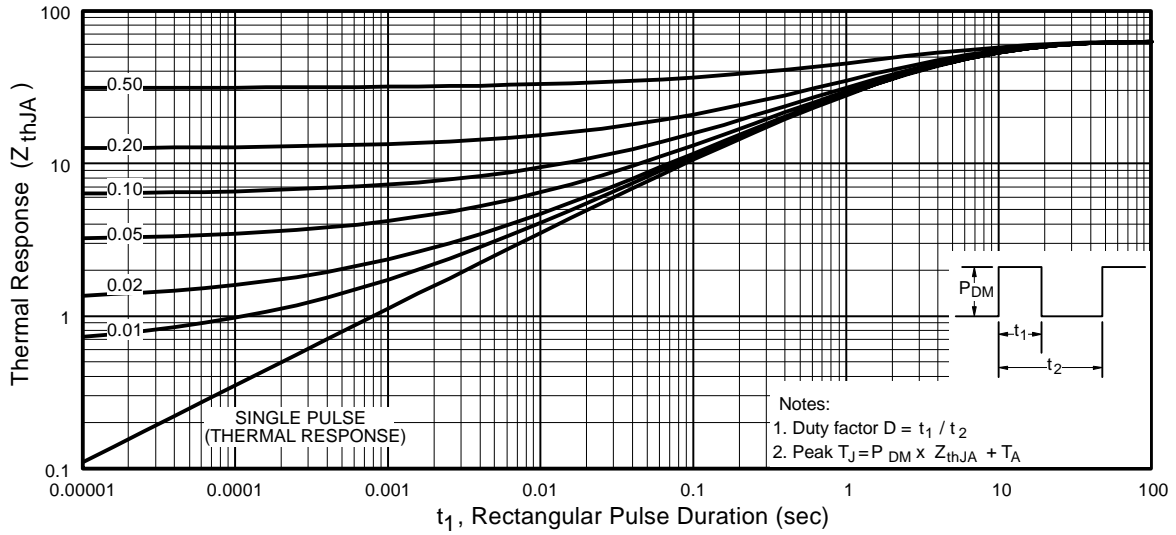


Fig9. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

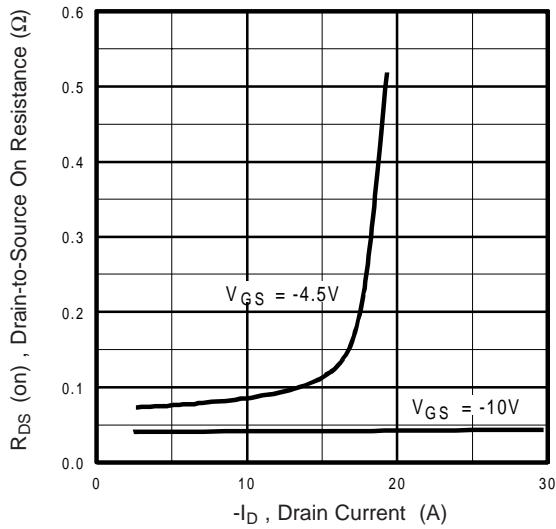


Fig 10. Typical On-Resistance Vs. Drain Current

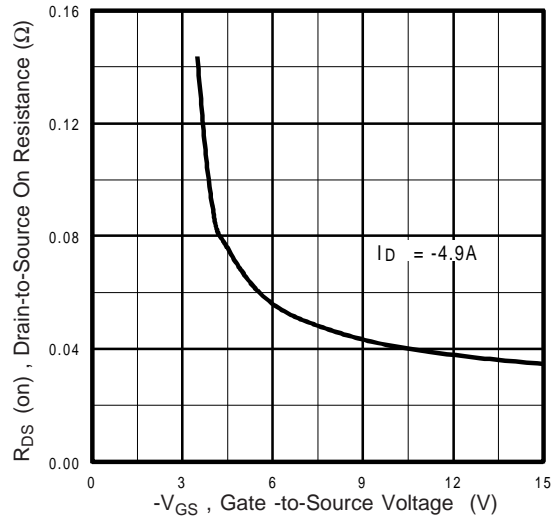
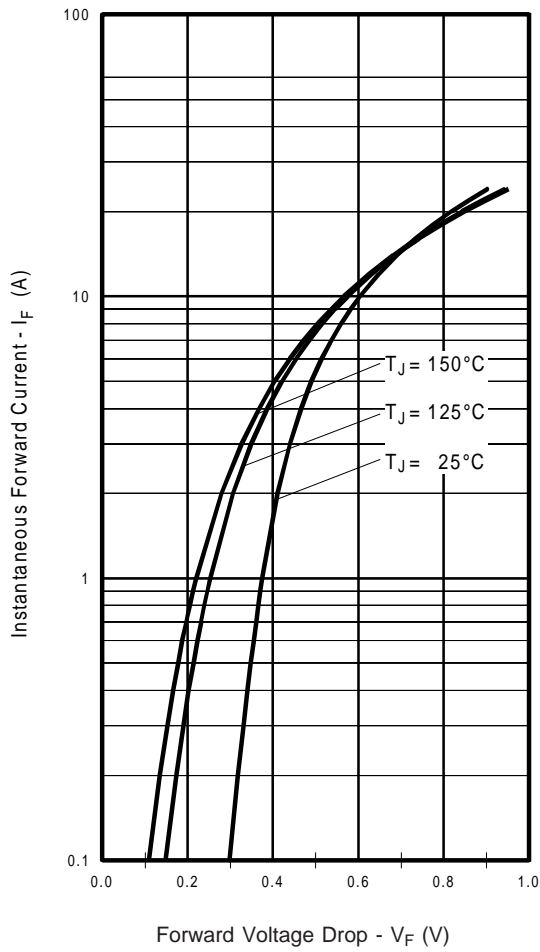
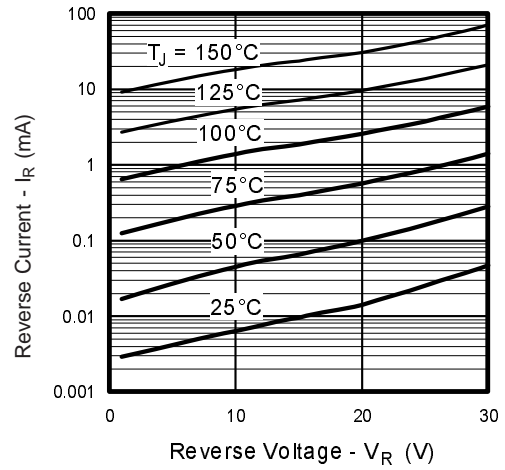


Fig 11. Typical On-Resistance Vs. Gate Voltage

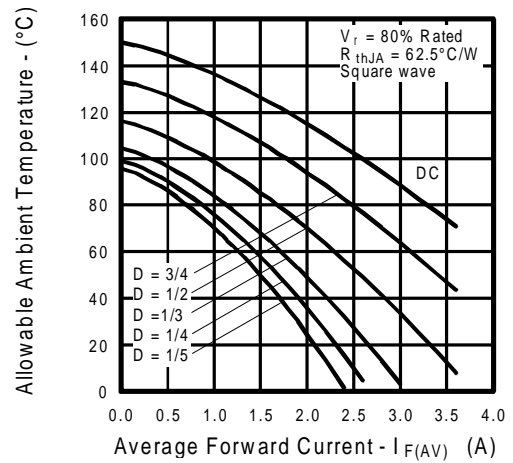
## Schottky Diode Characteristics



**Fig. 12** - Typical Forward Voltage Drop Characteristics

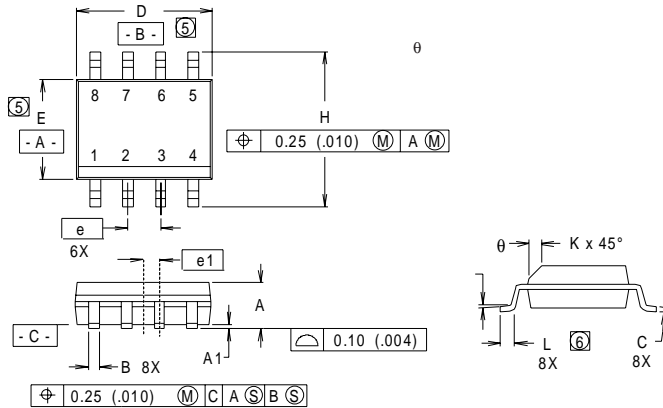


**Fig. 13** - Typical Values of Reverse Current Vs. Reverse Voltage



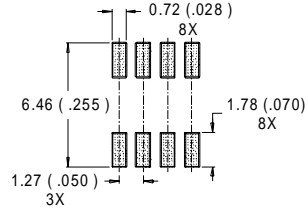
**Fig.14** - Maximum Allowable Ambient Temp. Vs. Forward Current

## SO-8 Package Details



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
B	.014	.018	0.36	0.46
C	.0075	.0098	0.19	0.25
D	.189	.196	4.80	4.98
E	.150	.157	3.81	3.99
e	.050 BASIC		1.27 BASIC	
e1	.025 BASIC		0.635 BASIC	
H	.2284	.2440	5.80	6.20
K	.011	.019	0.28	0.48
L	0.16	.050	0.41	1.27
$\theta$	0°	8°	0°	8°

RECOMMENDED FOOTPRINT

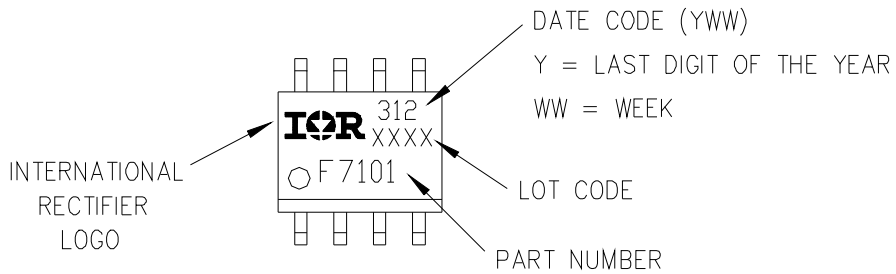


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1982.
2. CONTROLLING DIMENSION : INCH.
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
- ⑤ DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS  
MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.006).
- ⑥ DIMENSIONS IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE..

## Part Marking

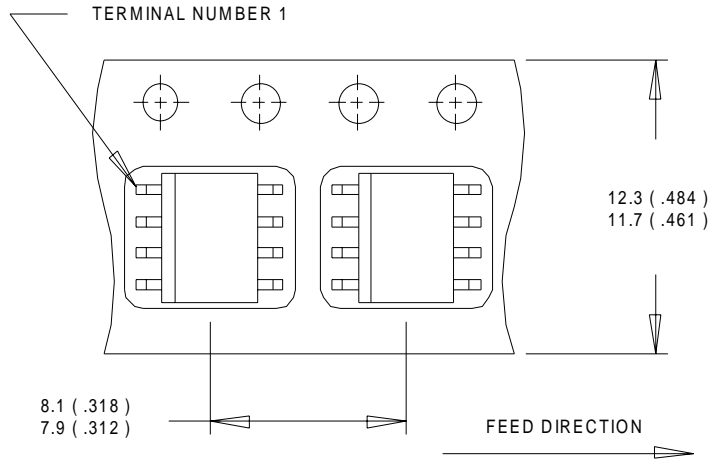
EXAMPLE: THIS IS AN IRF7101



# IRF7321D2

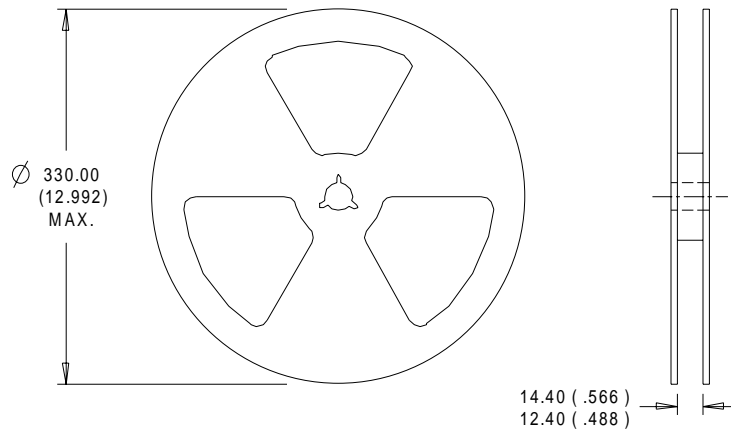
International  
**IR** Rectifier

## Tape and Reel



### NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



### NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

International  
**IR** Rectifier

**WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, Tel: (310) 322 3331

**IR GREAT BRITAIN:** Hurst Green, Oxted, Surrey RH8 9BB, UK Tel: ++ 44 1883 732020

**IR CANADA:** 15 Lincoln Court, Brampton, Ontario L6T3Z2, Tel: (905) 453 2200

**IR GERMANY:** Saalburgstrasse 157, 61350 Bad Homburg Tel: ++ 49 6172 96590

**IR ITALY:** Via Liguria 49, 10071 Borgaro, Torino Tel: ++ 39 11 451 0111

**IR FAR EAST:** K&H Bldg., 2F, 30-4 Nishi-Ikebukuro 3-Chome, Toshima-Ku, Tokyo Japan 171 Tel: 81 3 3983 0086

**IR SOUTHEAST ASIA:** 1 Kim Seng Promenade, Great World City West Tower, 13-11, Singapore 237994 Tel: ++ 65 221 8371

**IR TAIWAN:** 16 Fl. Suite D. 207, Sec. 2, Tun Haw South Road, Taipei, 10673, Taiwan Tel: 886-2-2377-9936

<http://www.irf.com/> Data and specifications subject to change without notice . 3/99